# Notice of References Cited Application/Control No. 10/046,249 Examiner Gail Verbitsky Applicant(s)/Patent Under Reexamination KIGUCHI ET AL. Page 1 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,960,147	09-1999	Muramatsu et al.	385/123
	В	US-6,515,277	02-2003	Kley, Vic B.	250/234
	С	US-5,939,709	08-1999	Ghislain et al.	250/216
	D	US-6,248,486	06-2001	Dirksen et al.	430/30
	Е	US-6,408,123 /	06-2002	Kuroda et al.	385/130
	F	US-2002/0064341 /	05-2002	Fauver et al.	385/25
	G	US-2003/0047675	03-2003	Proksch et al.	250/234
	Н	US-5,515,719 /	05-1996	Lindsay, Stuart	73/105
	1	US-5,321,502	06-1994	Matsumoto et al.	356/490
	J	US-2002/0115304 /	08-2002	Matsudo et al.	438/769
	к	US-6,025,913	02-2000	Curbelo, Raul	356/453
	L	US-4,571,650 /	02-1986	Ojima et al.	369/13.16
	М	US-6,127,681 /	10-2000	Sato et al.	. 250/306

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP200067459A	03-2000	JP	JP	G01H1/08
	0					
	·P					
	α					
	R					
	s	·				
	Т	_				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	·
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KIGUCHI ET AL. | Examiner | Art Unit | Page 2 of 3

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,006,594	12-1999	Karrai et al.	73/105
	В	US-6,400,449	06-2002	Maris et al.	356/72
	С	US-6,359,852	03-2002	Ueyanagi, Kiichi .	369/118
	D	US-5,288,999	02-1994	Betzig et al.	250/227.26 ·
	E	US-5,739,527	04-1998	Hecht et al.	250/234
	F	US-6,271,921 · (	08-2001	Maris et al.	356/432
	G	US-5,696,372	12-1997	Grober et al.	250/216
	Н	US-4,869,569	09-1989	Kapon, Elyahou	385/2
	1	US-5,708,638 /.	01-1998	Braat et al.	369/44.29
	J	US-4,909,082 /	03-1990	Khuri-Yakub et al.	73/642
	к	US-6,424,407 /	07-2002	Kinrot et al.	356/28
	L	US-2003/0036204 A1/	02-2003	Stark et al.	436/172
	М	US-2002/0166957 A1 /	11-2002	Oumi et al.	250/234

#### **FOREIGN PATENT DOCUMENTS**

*	ļ	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ρ	•				
	R					
	S				-	
	Т					-

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

#### 

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0154859 A1 /	10-2002	Kuroda et al.	385/31
	В	US-6,529,277	03-2003	Weitekamp, Daniel P.	356/445
	С	US-6,649,894 /	11-2003	Matsumoto et al.	250/201.3
	D	US-5,796,102	08-1998	Van Kempen et al.	250/306
	Ε	US-5,859,364 ∠	01-1999	Toda et al.	73/105
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	· K	US-			
	L	US-		·	
	·M	US-		·	

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	·
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.